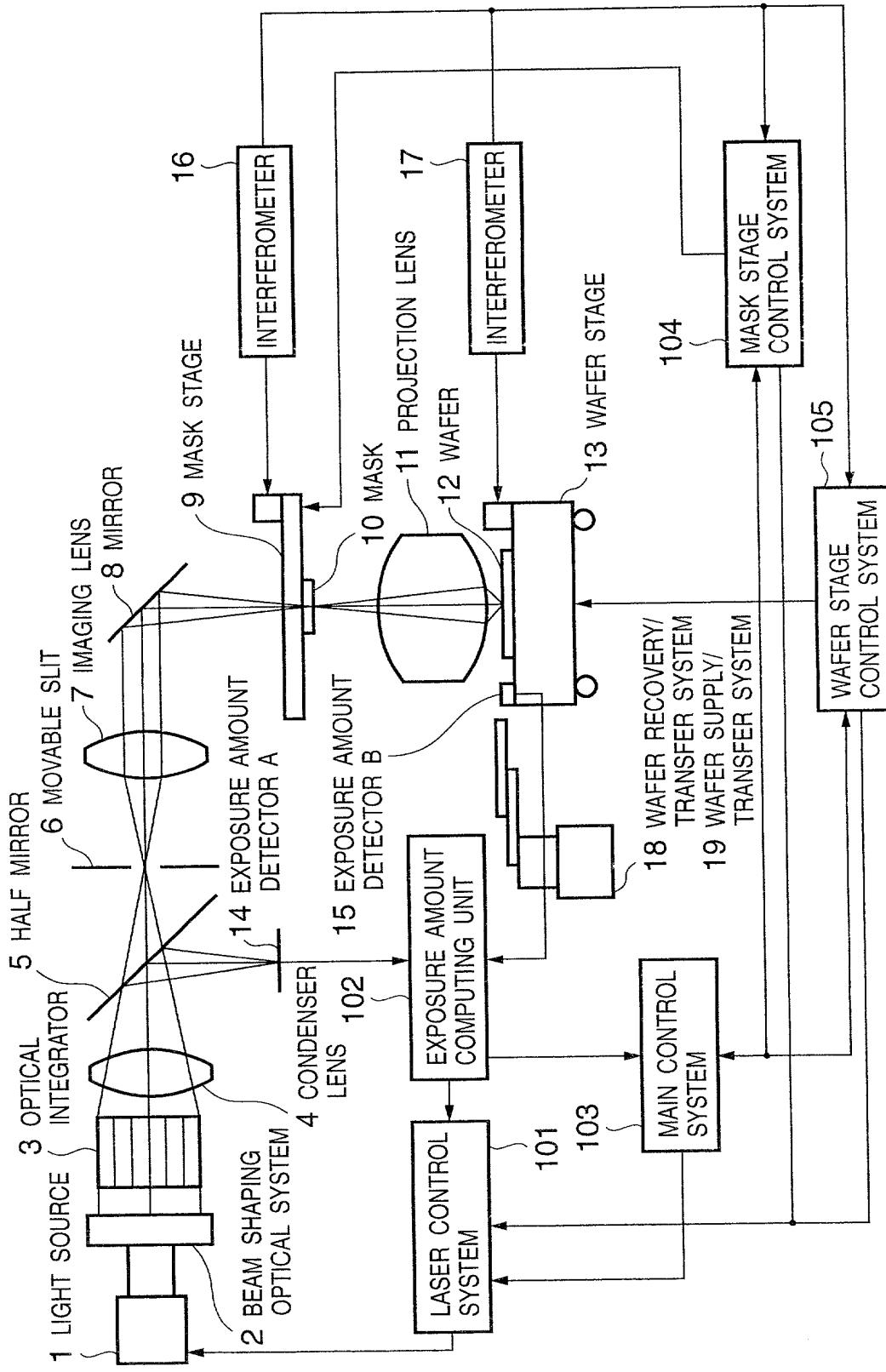


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FIG. 2

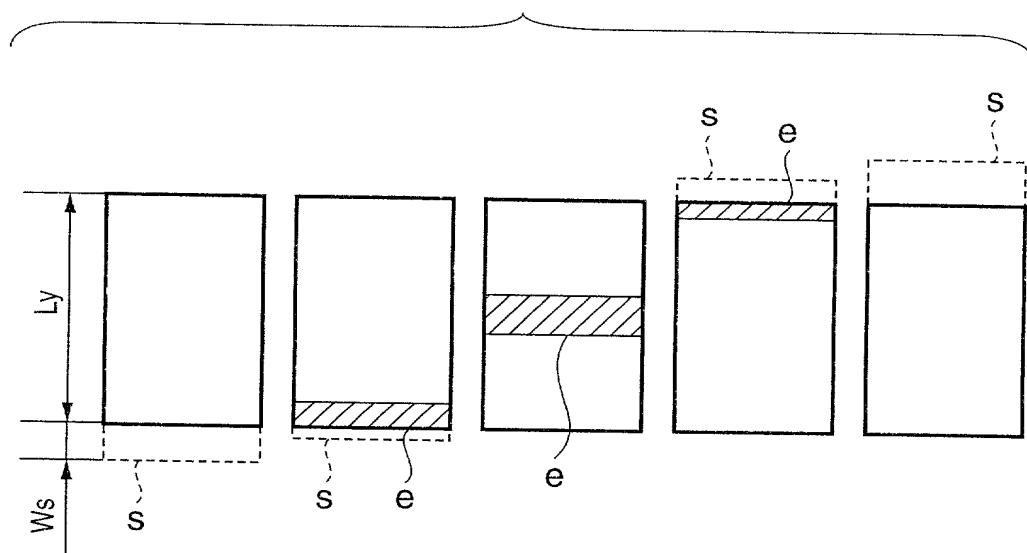


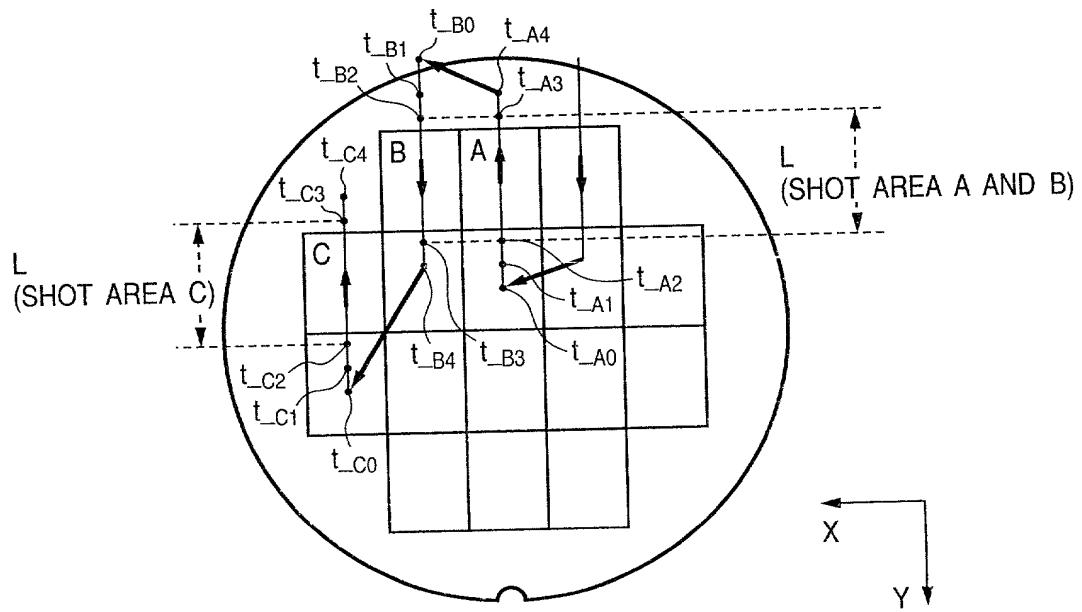
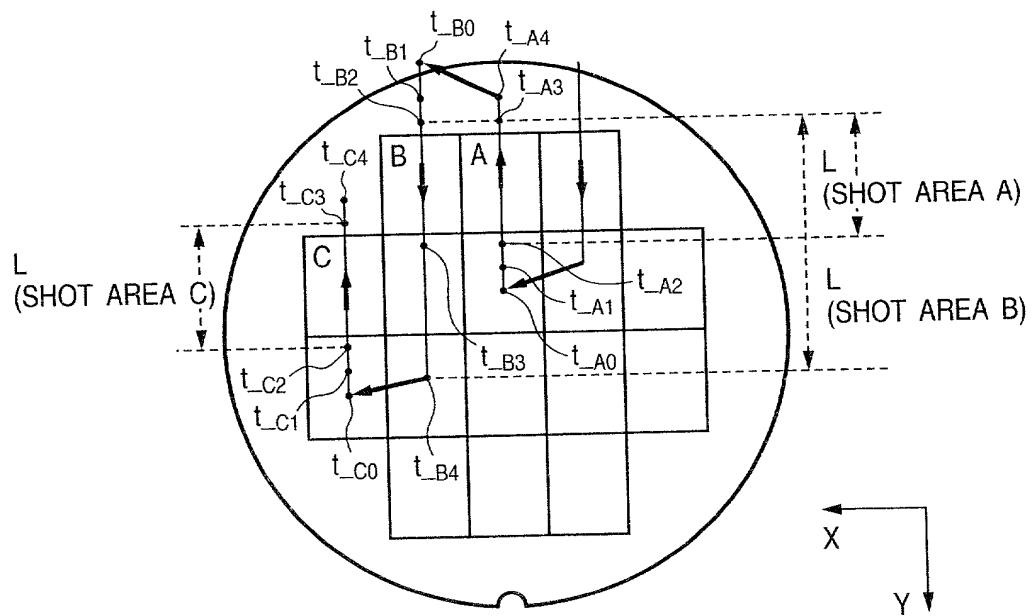
FIG. 3A**FIG. 3B**

FIG. 4

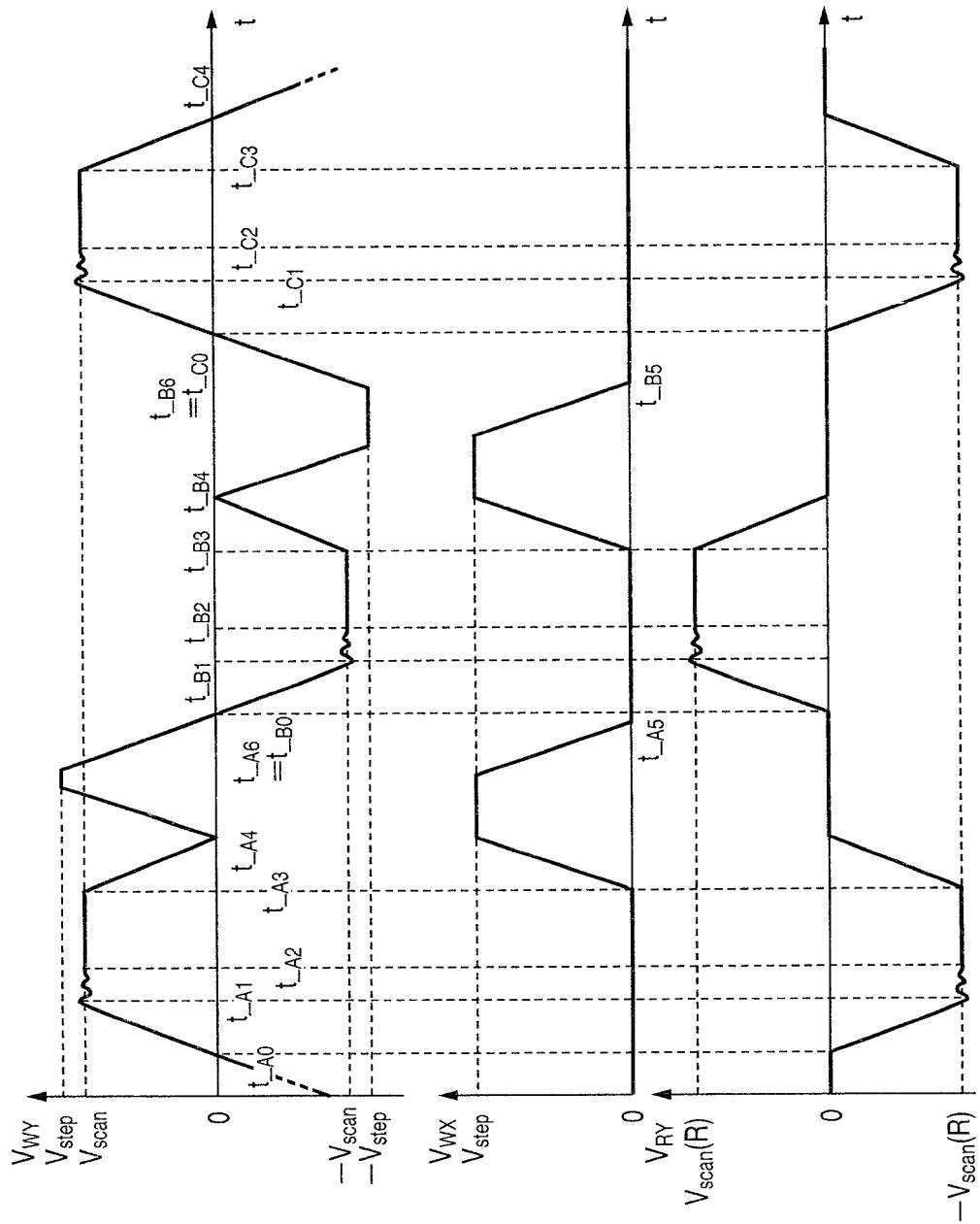
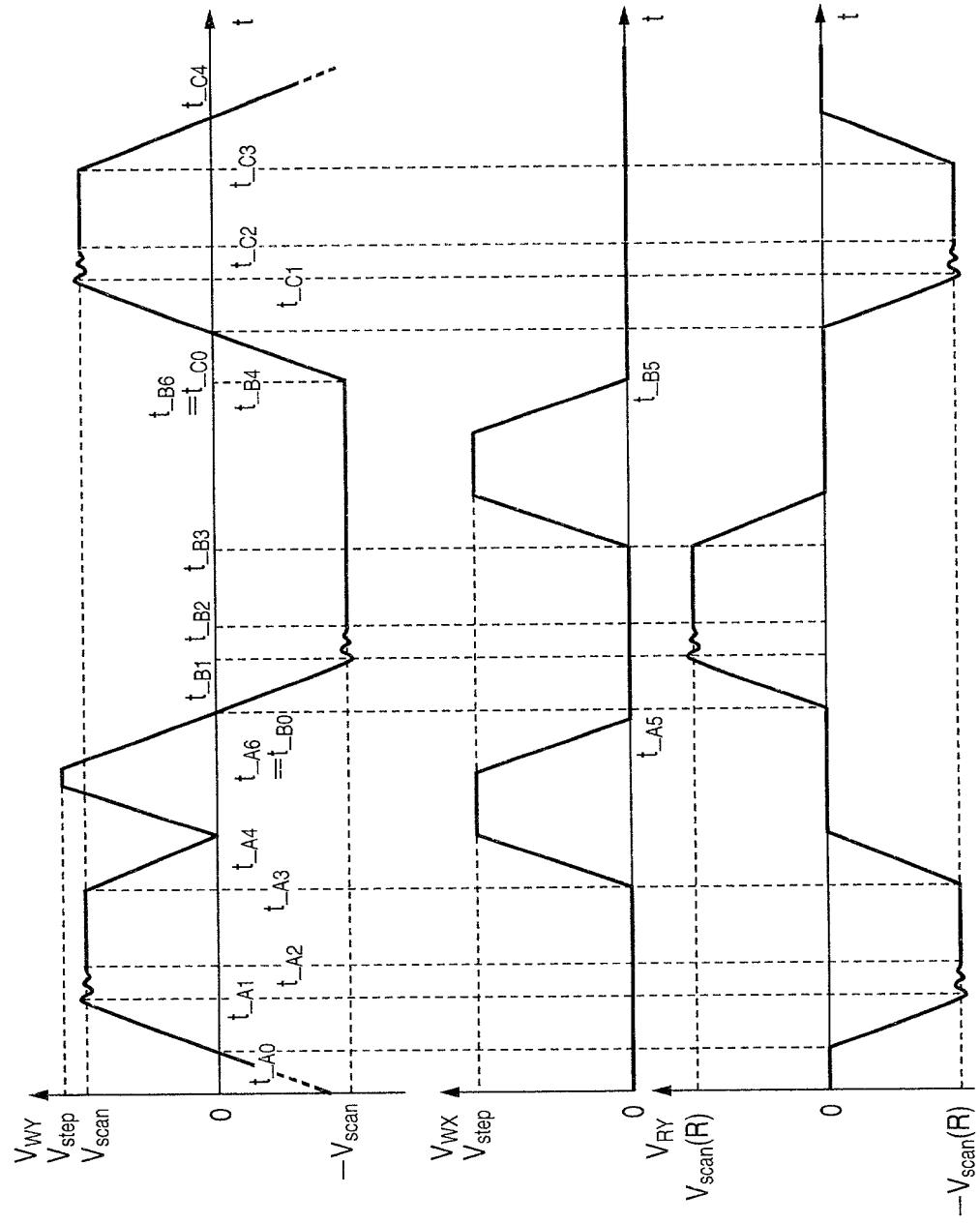


FIG. 5



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FIG. 6A

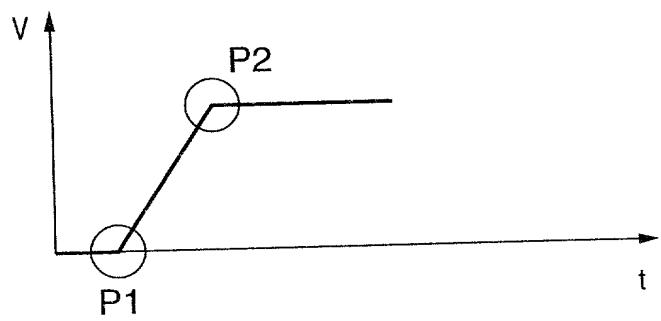


FIG. 6B

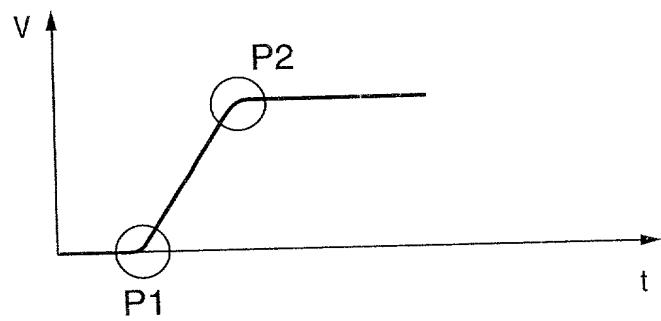


FIG. 7A

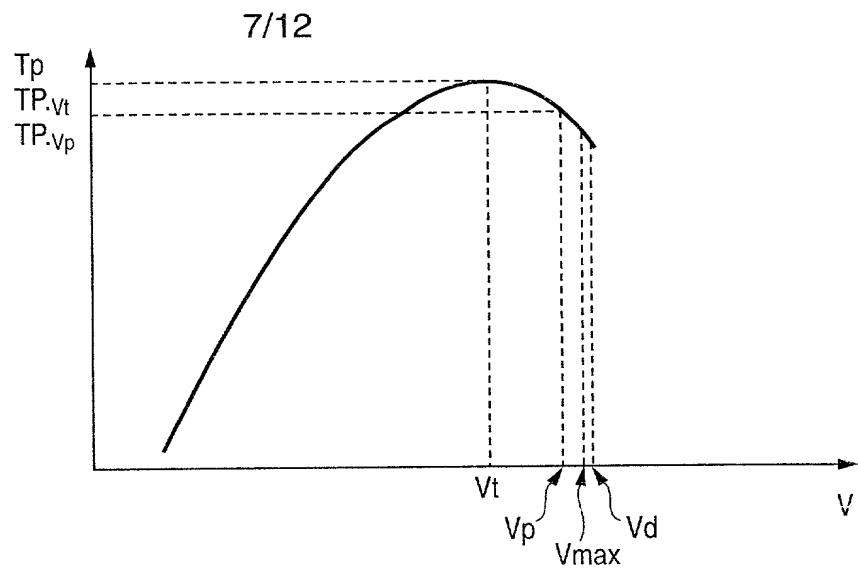


FIG. 7B

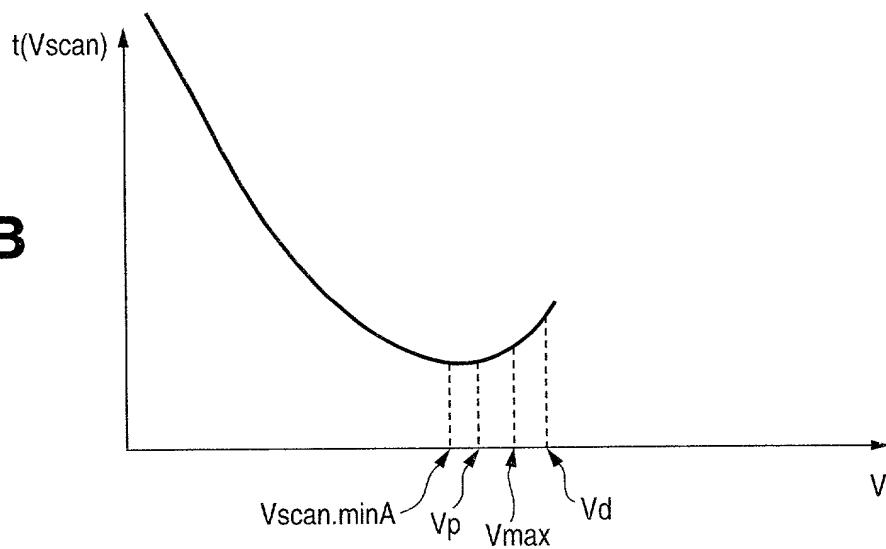


FIG. 7C

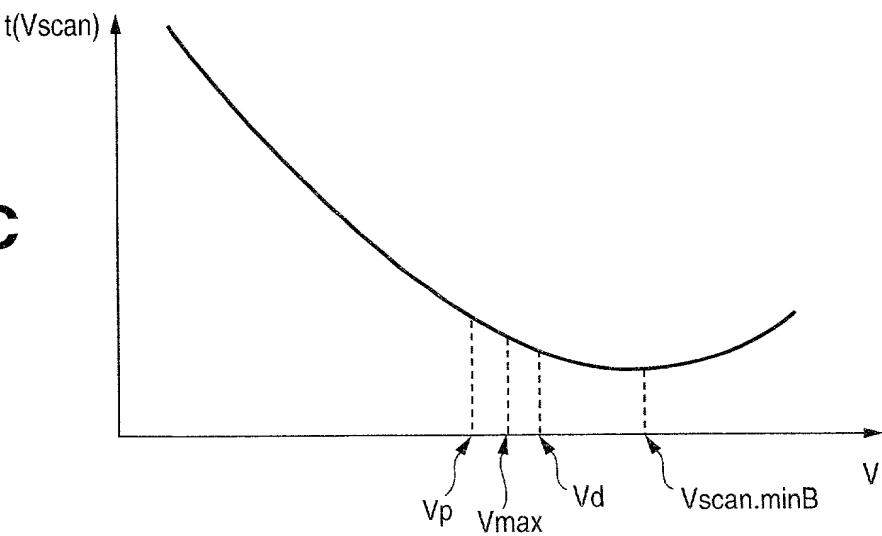


FIG. 8

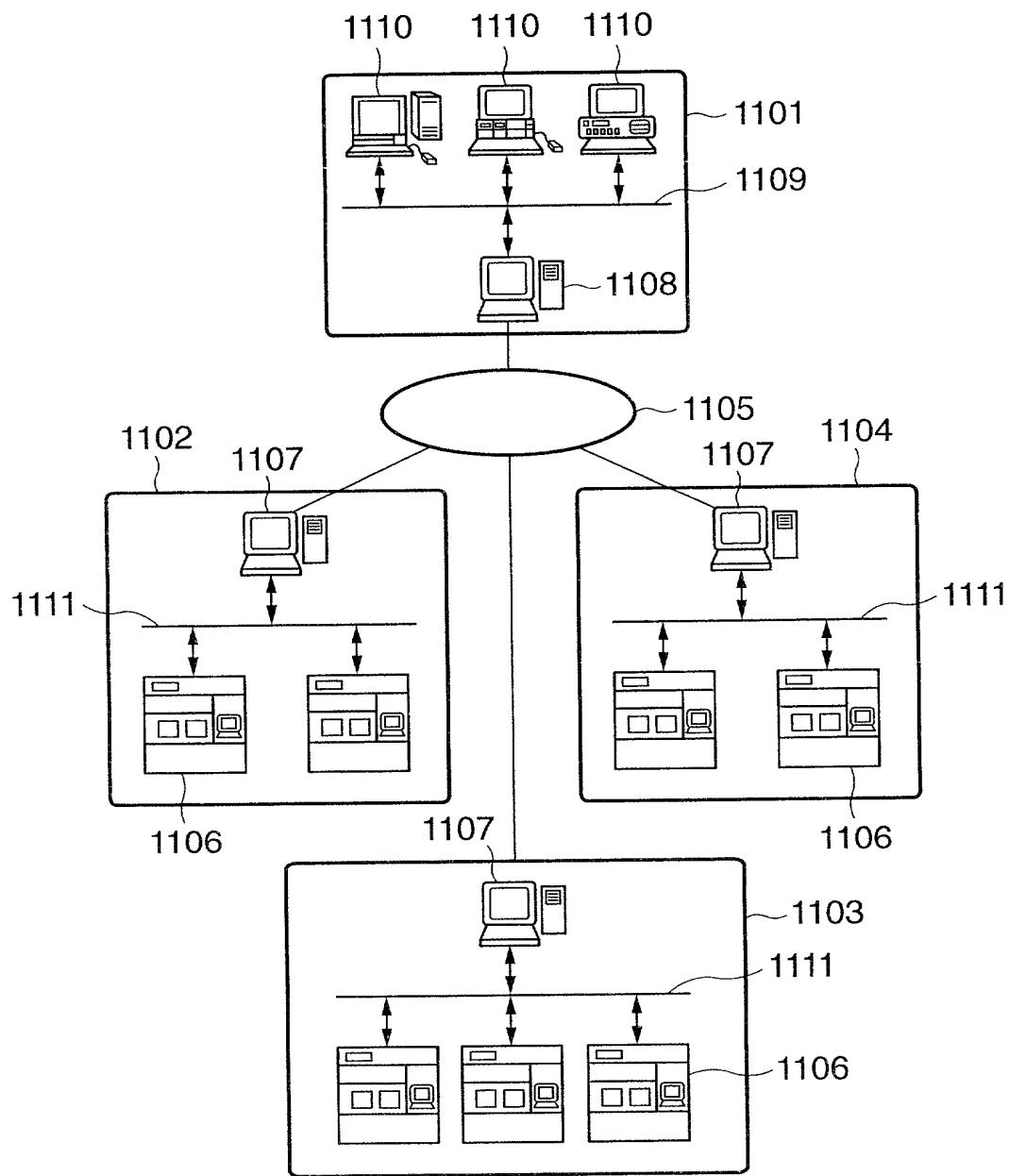


FIG. 9

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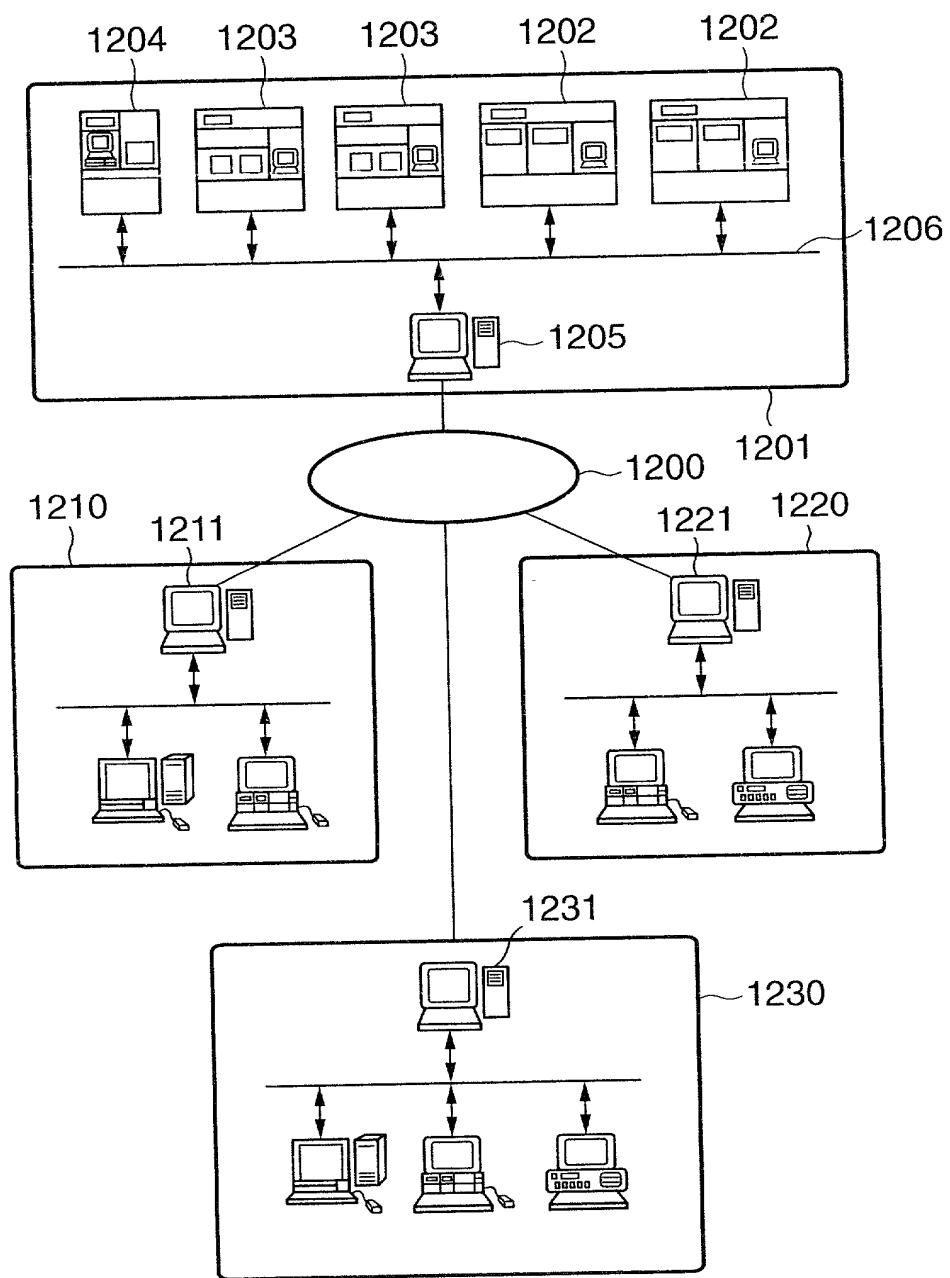


FIG. 10

URL <http://www.maintain.co.jp/db/input.html>

TROUBLE DB INPUT WINDOW

OCCURRENCE DATE 1404

TYPE OF APPARATUS 1401

OBJECT 1403

APPARATUS S/N 1402

DEGREE OF URGENCY 1405

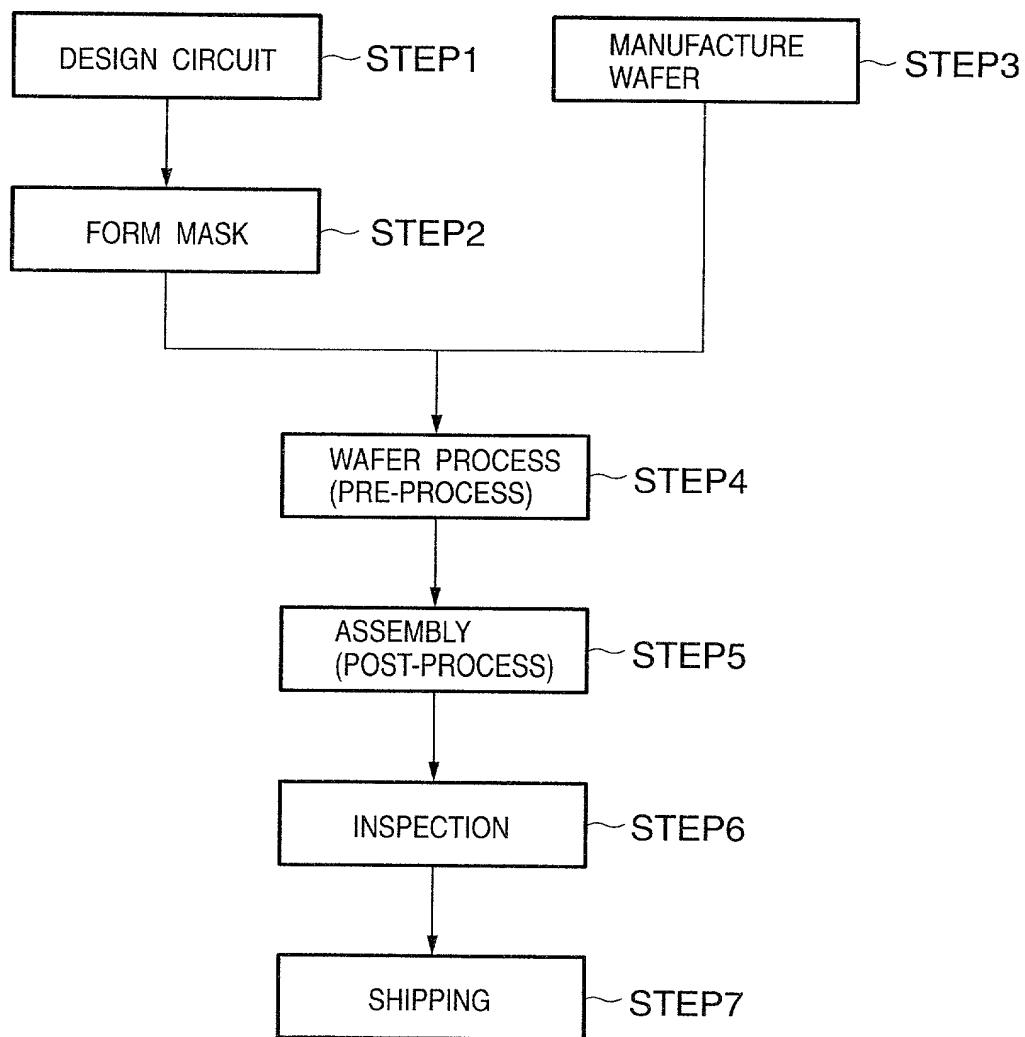
SYMPTOM 1406

REMEDY 1407

PROGRESS 1408

1410 1411 1412

FIG. 11



SEMICONDUCTOR DEVICE MANUFACTURING FLOW

FIG. 12

